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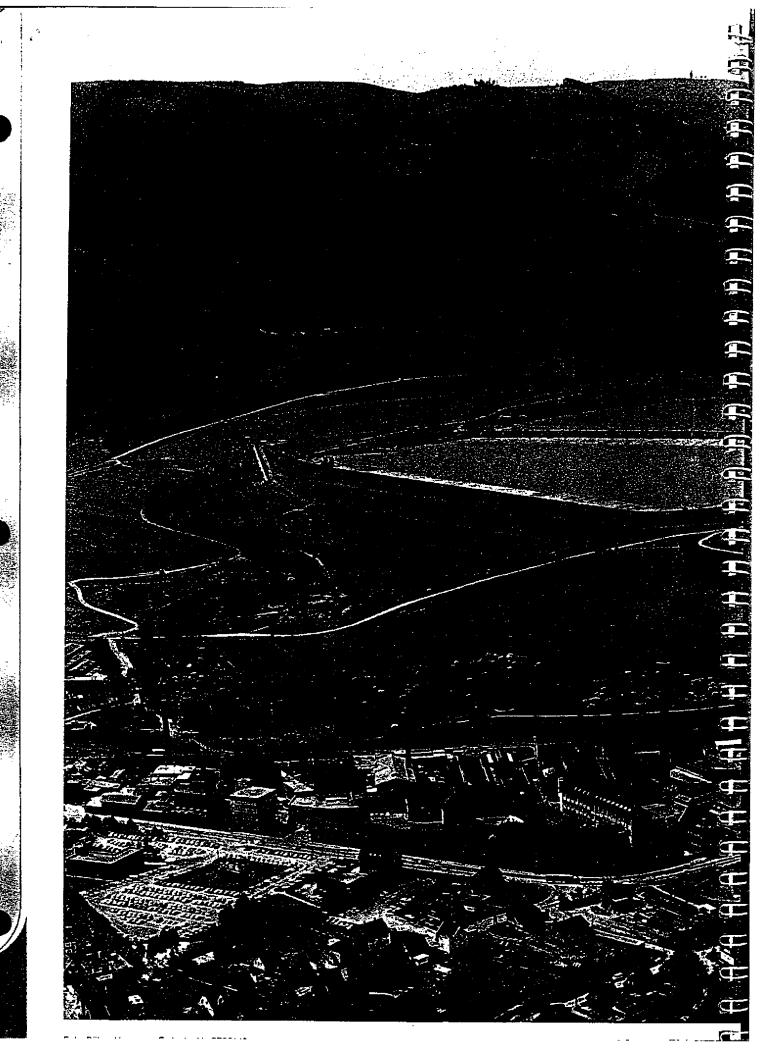
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Tantalum

Niobium



Metallurgical

HCST known world-wide for its high quality metallurgical products, has been involved with the production of tantalum since 1949.

Since this time **HCST** has developed into one of the most important and experienced producers of tantalum in the world.

The development of the past years has shown that a sound raw material policy is the most important pre-condition for a tantalum production.

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Therefore from the beginning **HCST** attached great importance to perform the tantalum extraction process in its own works starting from the raw material.

HCST therefore has designed and built extraction and separation plants for tantalum/niobium which permit great flexibility in operation by using wet chemical extraction or chlorination techniques.

This flexibility of operation permits the use of high grade tantalum ores such as tantalite and microlite with tantalum contents up to 70% as well as columbite and low grade by-products from other processes such as tin slags.

Besides **HCST** provides two ways to assure the supply of tantalum:

First, by developing new processes for recovering tantalum ores with lower and lower Ta-contents and secondly by developing Ta-powders for the capacitor industry with higher and higher capacitance thus insuring better utilization of the tantalum still available. (Powder type PL-18000 R today represents world-wide the powder with the highest yield of capacitance)

The research and development department of **HCST** is working very intensively in this field today.

The processes which are common practice at **HCST** are based on the application of the following **HCST** patents and the following pending patents:

DE-PS 2133104 DE-PS 2517180 v DE-PS 2537354 DE-PS 2610224

DE-OS 2733193 DE-OS 3005207 DE-OS 3113335 DE-OS 3130392

or of the corresponding foreign patents.

Tantalum by HCST

This catalogue deals with the tantalum and niobium products offered by **HCST**. Special importance is being attached to the powder grades used for the production of tantalum capacitors.

Tantalum and Niobium Products by HCST

The following items are included in our list of tantalum "Capacitor Grade" products:

1. Tantalum powder - "Capacitor Grade"

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- Series PL: Powders of high to highest capacitance for medium working voltage.
- Series 600: Powders of high purity of low to high capacitance for high to highest working
 - voltage.
- 2. Sintered tantalum anodes for electrolytic capacitors.
- 3. Niobium powder "Capacitor Grade" (on request).

Other tantalum and niobium products manufactured by **HCST** include:

- 5. Tantalum metal "Metallurgical Grade".
 - 5.1 Tantalum metal powder for powder metallurgy.
 - 5.2 Tantalum metal powder and pellets for melting.
 - 5.3 Tantalum scrap.
- 6. Tantalum for special purposes.
 - 6.1 Tantalum powder "Spraying Grade".
 - 6.2 Tantalum powder "Sub-Micron-Powder" (on request).
 - 6.3 Tantalum powder with especially high purity for scientific purpose.
- 7. Tantalum electron beam melted ingots.
- 8. Tantalum carbide, niobium carbide, tantalum-niobium carbide and tantalum-bearing triple and tetra carbides for the cemented carbide industry.
- Tantalum oxide, niobium oxide and tantalum-niobium oxide chemical pure and of highest purity for the optical and ceramic industry. This includes the application for ceramic capacitors also.
- Tantalum chloride, niobium chloride for surface coatings and other applications.
- 11. Potassium tantalum fluoride.

Should you be interested in these products, please ask for further informations.

Capacitor Grades

Metallurgical Grades PL-8000 represents the powder with the lowest yield of capacitance per gram and the highest working voltage in the PL-series. It has a good flowability and permits pressed densities down to 5.0 g/cm³. PL-8000 is recommended especially for the production of medium voltage 35 V capacitors.

Recommended conditions for processing

Sintering temperature: 1600 – 1850°C Sintering time: 15 – 30 minutes Pressed density: 5,0 – 6,0 g/cm³

can also be pressed

without binder

Yield of capacitance: 5000 - 8000 µFV/g (Wet test)

Working voltage:

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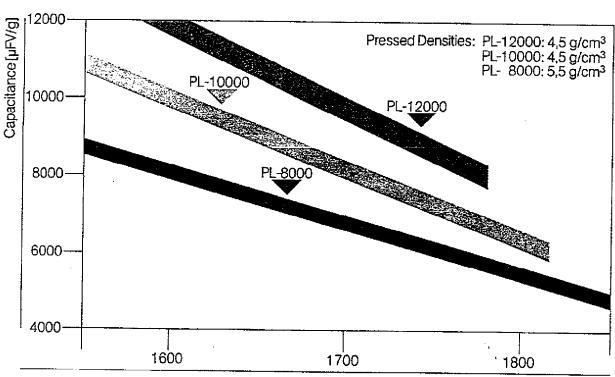
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up to 35 V

Typical Capacitance



Sintering Temperature [° C] [Sintering Time 30 min.]

Typical Electrical Characteristics

Grade	μFV/g	μFV/	Sintering Temperature		DCL	
		CITI'	(°C)	(V)	(nA/uFV)	
PL-8000 PL-8000 PL-8000	6800		1600 1700 1800	180 200 220	0,4 0,30 0.2	

Anode weight: 0,4 g, Pressed density: 5,5 g/cm³ Sintering time: 30 min, Formation voltage: 100 V

Series 600 (900)

660, 690-E, 690-S and 900-HC are the so-called "electron beam melted" powders. Their low contamination with impurities provides a high reliability at the highest working voltages.

The powders of this series are showing the following properties which are important for processing:

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- 1. They can be pressed without binder
- 2. They show an excellent flowability
- 3. The high strength of the agglomerates guarantees that the excess powder does not show any significant change in processing.

All the characteristics, such as capacitance per gram, capacitance per volume of the two powder series, are shown on the following tables.

In the attached data sheets you will find further particulars of the powders discussed.

Capacitance per Gram

Type µFV/g	1000	5000	10000	1500	20000
PL-18000R					
PL-12000					
PL-10000			property.		•
PL-8000				•	
900-HC					·
690-S					
690-E					
660					

Capacitance per Volume

µFV/cm³	10000	50000				100000
Type						
PL-18000R					2 500	
PL-12000			ί.			
PL-10000				<u>.</u>		
PL-8000				. •		i
900-HC		· ·		I		
690-\$						
690-E						
660						

Quality

Control

A considerable amount of highly skilled analytical effort is employed to ensure consistently high quality in our tantalum products. This applies even to the starting materials such as the ores and the chemicals used to process them.

Every step in the processing is carefully controlled, especially in the stages liable to have influence on the electrical, physical and chemical properties of the final product.

Among the methods we use are:

Determination of Metallic Contaminations

Emission spectroscopy Spectrophotometry X-ray fluorescence (3,5 m RSV, Plangitterspectrograph) (Spectronic 88, Bai

(Spectronic 88, Bausch & Lomb) (Philips PW 1450/PW 1410)

analysis Atom absorption

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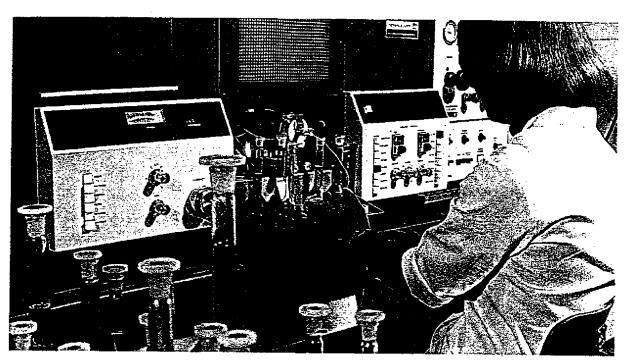
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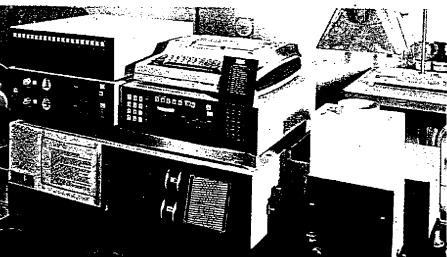
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(Perkin-Elmer 503)

Plasma Spectrometer (DC-Argon Plasma Echelle Spectrometer Spectrometrics Plasma Spectraspan III)





Atomic absorption spectrometer.

Plasma spectrometer

Determination of the Gas Content (Oxygen, Hydrogen, Nitrogen)

Vacuum fusion

(Leybold-Heraeus VH 9, Gas Evolograph 0583 St. Re (Leco TC 136)

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Inert-carrier-gas fusion

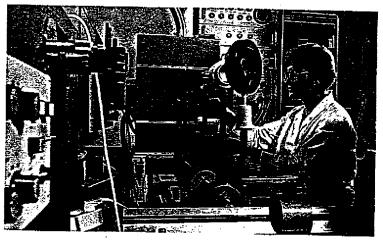
Determination of Carbon

Coulometric analysis

(Schoeps apparatus CTA 5 C)



Inert-carrier-gas fusion (Leco TC 136)



3.5-m plane grating spectograph for photographic and photoelectric recording, combined with an arc-sparc stand and a glow discharge lamp.

Physical Properties

Scott density (Scott, ASTM: B 329 - 76) Average particle size (Fisher Sub-Sieve Sizer,

ASTM: B 330 - 82)

Screen distribution Flow properties

(DIN or ASTM: B 214 - 76, E 11)

(Hall-Flow-Index, ASTM: B 213 - 77)

Particle size distribution

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(Sedimentation: WAB, ASTM: B 430 - 79)

Roller Analyzer, ASTM: 293 - 76)

In addition these are several methods for determining further physical properties by means of

Scanning Electron

(Jeol JSM-T100, JSM-35 C)

Microscope

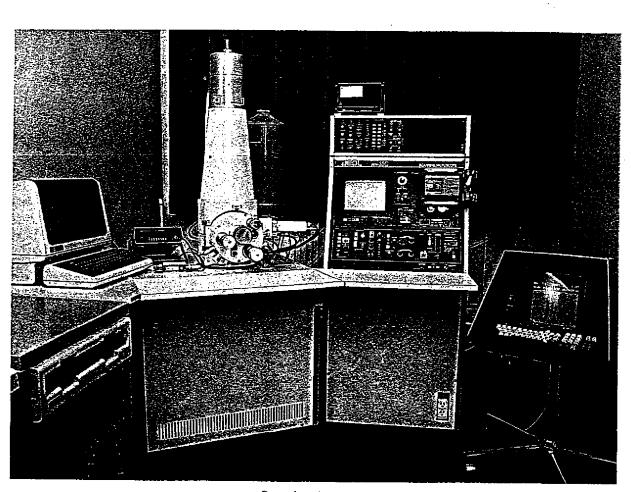
Mercury Porosimetry

(DIN 66132)

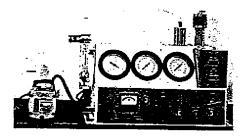
and BET method specific surface

Sedigraph

(5000 D, Micromeritics)



Scanning electron microscope with energy dispersive micro-analysis



Test Conditions (Wet Test)

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	270 V	200 V	100 V (70 V)	
Formation conditions				
Electrolyte	0,01 wt-% H ₃ PO ₄	0,01 wt-% H ₃ PO ₄	0.04+ 0/11.0	
Temperature	90±2°C	90±2°C	0,01 wt-% H₃P 90±2°C	
Formation voltage	270 V	200 V		
Final voltage held for	120 min	120 min	100 V (70 V)	
Formation Current	35 mA/g		120 min	
	(0-200 V)	35 mA/g	35 mA/g	
	(0-200 V) 12 mA/g			
	(201–270 V)			
deasurement condition	ons for capacitance and l	ESR (after washing and	drying)	
ectrolyte	10 wt-% H3PO4	10 wt-% H ₃ PO ₄	10 wt-% H ₃ PO ₄	
emperature	23±2°C	23±2°C	23±2°C	
D.C. Bias	2,0 V	2,0 V	2,0 V	
I.C. Signal	0,5 V	0,5 V	0,5 V	
			U,U V	
requency	120 cps	120 cps	120 cps	
leasurement conditio	ns for leakage current			
Measurement conditio	ns for leakage current 10 wt-% HsPO4	10 wt-% H₃PO4	10 wt-% H ₃ PO ₄	
feasurement conditio lectrolyte emperature	ns for leakage current 10 wt-% HsPO4 23 ± 2°C	10 wt-% H₃PO₄ 23 ± 2°C	10 wt-% HaPO ₄ 23 ± 2°C	
Measurement conditio lectrolyte emperature oltage	ns for leakage current 10 wt-% HsPO4	10 wt-% H₃PO4	10 wt-% H ₃ PO ₄	
Measurement condition lectrolyte emperature oltage charging time	ns for leakage current 10 wt-% HaPO4 23 ± 2°C 240 V 2 min	10 wt-% H₃PO₄ 23 ± 2°C 140 V 2 min (after washing and dryin	10 wt-% HaPO4 23 ± 2°C 70 V (47 V) 2 min	
Measurement condition lectrolyte emperature oltage charging time leasurement condition lectrolyte	ns for leakage current 10 wt-% HsPO4 23 ± 2°C 240 V 2 min ns for dissipation factor 10 wt-% HsPO4	10 wt-% HaPO4 23 ± 2°C 140 V 2 min (after washing and dryin 10 wt-% HaPO4	10 wt-% HaPO4 23 ± 2°C 70 V (47 V) 2 min	
Measurement conditional lectrolyte emperature foltage charging time lectrolyte emperature emperature emperature emperature	ns for leakage current 10 wt-% HsPO4 23 ± 2°C 240 V 2 min ns for dissipation factor 10 wt-% HsPO4 23 ± 2°C	10 wt-% HaPO4 23±2°C 140 V 2 min (after washing and dryin 10 wt-% HaPO4 23±2°C	10 wt-% HaPO4 23 ± 2°C 70 V (47 V) 2 min	
Measurement condition lectrolyte emperature condition control to the condition lectrolyte emperature emperature.	ns for leakage current 10 wt-% H ₃ PO ₄ 23 ± 2°C 240 V 2 min ns for dissipation factor 10 wt-% H ₃ PO ₄ 23 ± 2°C 2,0 V	10 wt-% HaPO4 23 ± 2°C 140 V 2 min (after washing and dryin 10 wt-% HaPO4 23 ± 2°C 2,0 V	10 wt-% HaPO4 23 ± 2°C 70 V (47 V) 2 min	
Measurement conditional lectrolyte emperature described in the conditional lectrolyte emperature emperature. C. Bias C. Signal	ns for leakage current 10 wt-% HsPO4 23 ± 2°C 240 V 2 min ns for dissipation factor 10 wt-% HsPO4 23 ± 2°C 2,0 V 0,5 V	10 wt-% HaPO4 23±2°C 140 V 2 min (after washing and dryin 10 wt-% HaPO4 23±2°C 2,0 V 0,5 V	10 wt-% HaPO4 23 ± 2°C 70 V (47 V) 2 min 9) 10 wt-% HaPO4 23 ± 2°C	
Measurement conditional lectrolyte lectrolyte lemperature conditional lectrolyte lectrolyte lectrolyte lemperature lectrolyte lectrolyte lemperature lectrolyte l	ns for leakage current 10 wt-% H ₃ PO ₄ 23 ± 2°C 240 V 2 min ns for dissipation factor 10 wt-% H ₃ PO ₄ 23 ± 2°C 2,0 V	10 wt-% HaPO4 23 ± 2°C 140 V 2 min (after washing and dryin 10 wt-% HaPO4 23 ± 2°C 2,0 V	10 wt-% H ₃ PO ₄ 23±2°C 70 V (47 V) 2 min 9) 10 wt-% H ₃ PO ₄ 23±2°C 2,0 V	
Measurement condition lectrolyte emperature foltage Charging time Measurement condition lectrolyte emperature .C. Bias .C. Signal requency	ns for leakage current 10 wt-% H ₃ PO ₄ 23±2°C 240 V 2 min ns for dissipation factor 10 wt-% H ₃ PO ₄ 23±2°C 2,0 V 0,5 V 120 cps	10 wt-% H ₃ PO ₄ 23±2°C 140 V 2 min (after washing and dryin 10 wt-% H ₃ PO ₄ 23±2°C 2,0 V 0,5 V 120 cps	10 wt-% HaPO4 23±2°C 70 V (47 V) 2 min 9) 10 wt-% HaPO4 23±2°C 2,0 V 0,5 V	
Measurement conditional lectrolyte remperature remperature remperature remperature remperature remperature remperature requency	ns for leakage current 10 wt-% HsPO4 23 ± 2°C 240 V 2 min ns for dissipation factor 10 wt-% HsPO4 23 ± 2°C 2,0 V 0,5 V	10 wt-% H ₃ PO ₄ 23±2°C 140 V 2 min (after washing and dryin 10 wt-% H ₃ PO ₄ 23±2°C 2,0 V 0,5 V 120 cps	10 wt-% H ₃ PO ₄ 23±2°C 70 V (47 V) 2 min g) 10 wt-% H ₃ PO ₄ 23±2°C 2,0 V 0,5 V 120 cps	
emperature /oltage Charging time Measurement condition lectrolyte emperatureC. BiasC. Signal requency	ns for leakage current 10 wt-% HaPO4 23 ± 2°C 240 V 2 min ns for dissipation factor 10 wt-% HaPO4 23 ± 2°C 2,0 V 0,5 V 120 cps	10 wt-% H ₃ PO ₄ 23±2°C 140 V 2 min (after washing and dryin 10 wt-% H ₃ PO ₄ 23±2°C 2,0 V 0,5 V 120 cps	10 wt-% HaPO4 23±2°C 70 V (47 V) 2 min 9) 10 wt-% HaPO4 23±2°C 2,0 V 0,5 V	

PL-8000 represents the powder with the lowest yield of capacitance per gram and the highest working voltage in the PL-series. It has a good flowability and permits pressed densities down to 5.0 g/cm³. PL-8000 is recommended especially for the production of medium voltage 35 V capacitors.

Recommended conditions for processing

Sintering temperature: 1600 – 1850°C Sintering time: 15 – 30 minutes

Pressed density: 5.0 - 6.0

5,0 - 6,0 g/cm³ can also be pressed

without binder

Yield of capacitance: 500

5000 - 8000 µFV/g (Wet test)

Working voltage:

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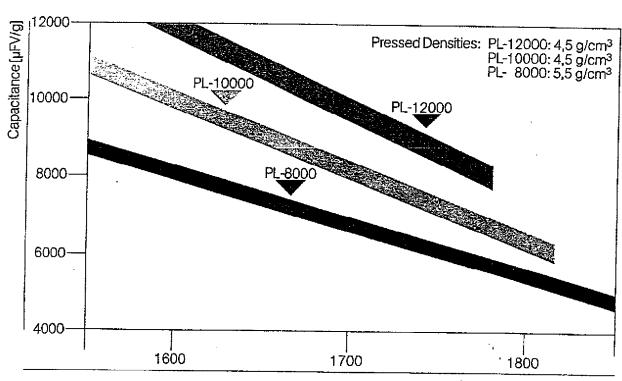
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up to 35 V

Typical Capacitance



Sintering Temperature [° C] [Sintering Time 30 min.]

Typical Electrical Characteristics

Grade			Sintering Temperature	VBD	DCL
		CITIS	(°C)	(V)_	(nA/uFV)
PL-8000 PL-8000 PL-8000	6800	47500 44000 38500		180 200 220	0,4 0,30 0,2

Anode weight: 0,4 g, Pressed density: 5,5 g/cm³ Sintering time: 30 min, Formation voltage: 100 V

PL-8000

Typical Chemical Analysis

<u>Elements</u> H N O C Fe Nb Si Ti W Mo ppm 10 75 2000 75 50 50 50 10 20 20

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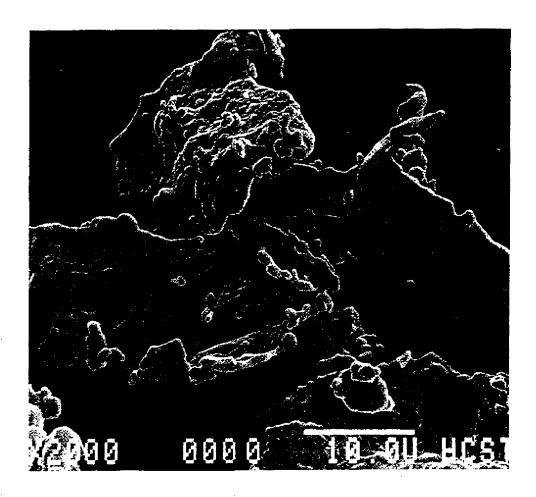
Typical Physical Characteristics

Scott Density (according to ASTM No. B 329-76)

g/in³: 30 -40 g/cm³: 1,8- 2,4

Fisher Sub-Sieve Size (according to ASTM No. B 330–82) µm: 4,0 – 5,5

Screen Distribution (according to ASTMNo. B 214-76, E11)



PL-10000 was the first powder with a yield of capacitance of more than 10000 µFV/g. Its excellent physical properties permit pressed densities down to 4.0 g/cm³. PL-10000 is recommended for the production of capacitors up to 35 V.

Recommended conditions for processing

Sintering temperature: 1600–1750°C
Sintering time: 15 –30 minutes
Pressed density: 4,0 – 5,0 g/cm³

can also be pressed

without binder

Yield of capacitance:

7500-10000 µFV/g (Wet test)

Working voltage:

up to 35 V

Typical Capacitance

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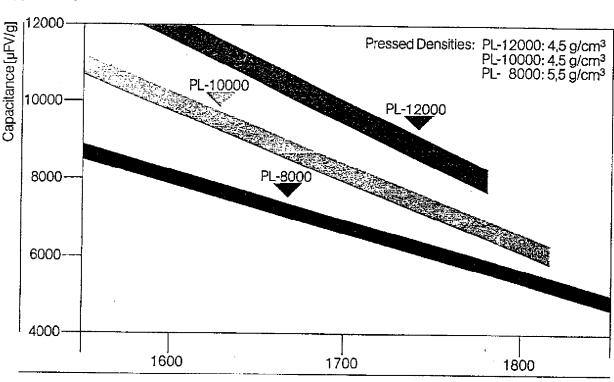
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Sintering Temperature [° C] [Sintering Time 30 min.]

Typical Electrical Characteristics

Grade	μFV/g	μ FV /	Sintering Temperature	VBD	DCL
		cm ³	(°C) '	(V)	(nA/µFV)
PL-10000		49000	1600	170	0,5
PL-10000		47000	1650	180	0,4
PL-10000	8200	45000	1700	190	0,3

Anode weight: 0,4 g, Pressed density: 4,5 g/cm³ Sintering time: 30 min, Formation voltage: 100 V

· PL=10000

Typical Chemical Analysis

Elements	H	Ν	0	С	F <u>e</u>	Nb	Si	_Ti	<u>W</u> .	<u> Mo</u>
			2400							

Typical Physical Characteristics

Scott Density (according to ASTM No. B 329-76)

g/in³ : 20 ~35 g/cm³ : 1,2- 2,1

Fisher Sub-Sieve Size (according to ASTM No. B 330-82) um: 2,5 - 4,5

 Screen Distribution (according to ASTM No. B 214−76, E11)

 +200 mesh
 −200+325 mesh
 −325 mesh

 10−30%
 10−30%
 40−60%

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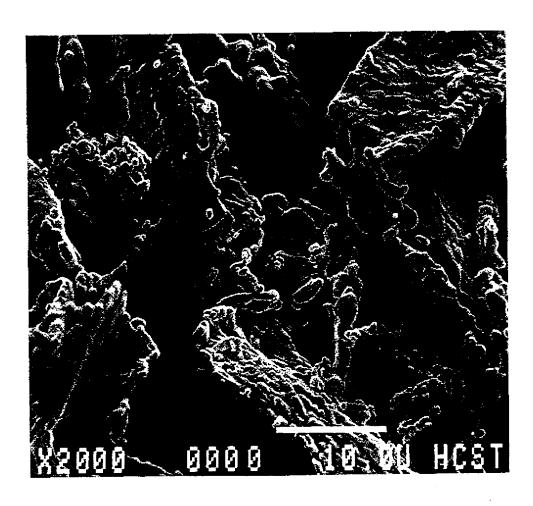
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Tantalum Powder Capacitor Grade Grade PL-12000

PL-12000

PL-12000 today represents the powder with the highest yield of capacitance at normal sinterconditions of minimum 1600 °C, 30 min (12000 µFV/g). Its high green strength also permits pressed densities of 4,0 - 5,0 g/cm3. PL-12000 corresponds to the data of PL-10000 as to its processing qualities.

Recommended conditions for processing

Sintering temperature: 1600 – 1750°C Sintering time: 15 - 30 minutes Pressed density; $4,0 - 5,0 \text{ g/cm}^3$

can be pressed without binder

Yield of capacitance:

9000 - 12000 µFV/g (Wet test)

Working voltage

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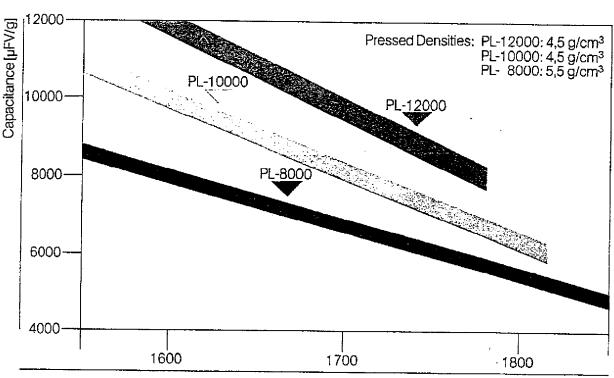
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up to 35 V

Typical Capacitance



Sintering Temperature P CI [Sintering Time 30 min.]

Typical Electrical Characteristics

Grade	μFV/g	uFV/	Sintering Temperature	VBD	DCL
		cm ³	(°C)	(V)	(nA/µFV)
PL-12000				160	0,5
PL-12000			1650	170	0.35
PL-12000	9800	50000	1700	180	0,25

Anode weight: 0,4 g, Pressed density: 4,5 g/cm³ Sintering time: 30 min, Formation voltage: 100 V

PL-12000

Typical Chemical Analysis

<u>Elements</u> <u>H N O C Fe Nb Si Ti W Mo</u> ppm 10 200 2700 100 50 50 50 10 20 20

Typical Physical Characteristics

Scott Density (according to ASTM: B 329-76)

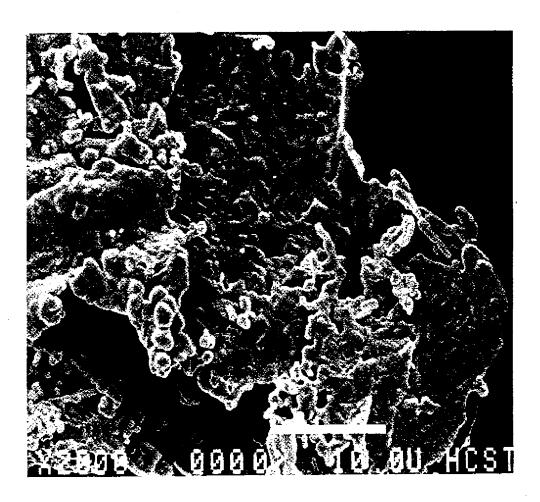
 g/in^3 : 15 - 25 g/cm^3 : 0,9 - 1,5

Fisher Sub-Sieve Size (according to ASTM No. B 330-82) µm: 2,0 - 3,5

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Screen Distribution (according to ASTM: B 214-76, E 11)

+200 mesh	-200 +325 mesh	-325 mesh
10-30%	10-30%	40-60%



Tantalum Powder Capacitor Grade Grade PL-18000 R

PL-18000 R is a consistent improvement over PL-18000 with regard to better physical properties like flowability and green strength at low pressed density.

Further on it can be characterized by an outstanding low level of oxygen which has to be related to the high capacitance of this powder.

Because of the improved stability of PL-18000 R particles preparation of pellets is possible at a green density of 4,5 g/cm³.

Recommended conditions for processing

Sintering temperature: 1550–1700 ℃ Sintering time: -20 minutes Pressed density: 4,5-5,5 g/cm3

can be pressed without binder

Yield of capacitance: 13000-18000 uFV/g

(wet test)

Working voltage: up to 25 V

Typical Capacitance

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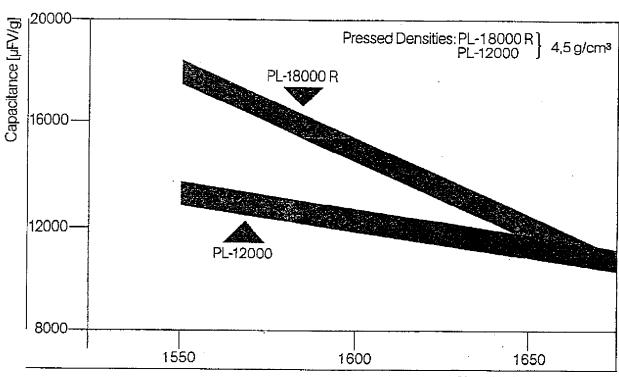
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Sintering Temperature [°C] [Sintering Time 20 min]

Typical Electrical Characteristics

Grade	μFV/g	μFV/	Sintering Temperature		DCL
			(°C)	(V)	(nA/µFV)
PL-18000 F			1550	120	0,3
PL-18000 P				130	0,3
PL-18000 F	12000	77500	1650	140	0,2

Anode weight: 0,2 g, Pressed density: 4,5 g/cm³ Sintering time: 20 min. Formation voltage: 70 V

PL-18000 R

Typical Chemical Analysis

Elements N O C Fe Nb Si Ti W Mo ppm 200 1700 90 60 50 50 10 20 20

Typical Physical Characteristics

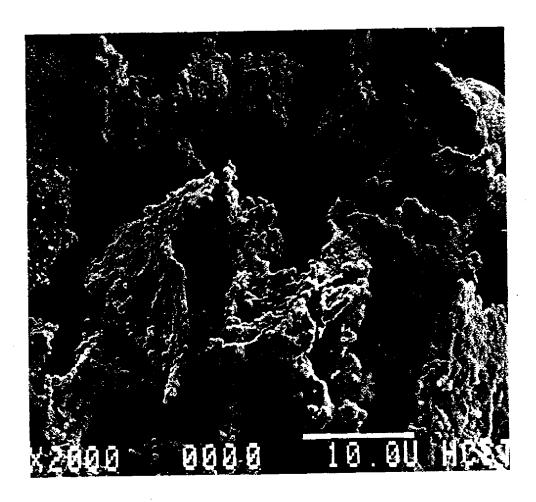
Scott Density (according to ASTM: B 329-76)

g/in³: 15-20 g/cm³: 0,9-1,3

Fisher Sub-Sieve Size (according to ASTM: B 330-82)

μm : 0,9-1,8

Screen Distribution (according to ASTM: B 214-76, E 11 100%-45 mesh



PL-22000 combines all the qualities of the PL-series with the highest yield of capacitance presently available in the market.

Its remarkably high yield of capacitance per unit volume should allow a further miniturization of capacitors under fixed conditions.

Recommended conditions for processing

Sintering temperature:

1500–1700 °C 5–20 minutes

Sintering time: Pressed density:

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4.5-5.5 g/cm³

Yield of capacitance:

can be pressed without binder

a of capacitance:

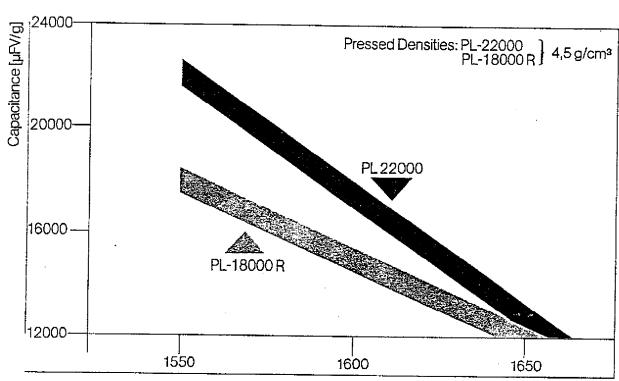
15000-22000 µFV/g

(wet test)

Working voltage:

upto 25 V

Typical Capacitance



Sintering Temperature [°C] [Sintering Time 20 min]

Typical Electrical Characteristics

Grade	μFV/g	μFV/	Sintering Temperature		DCL
			(°C)	(V)	(nA/µFV)
PL-22000				120	0.3
PL-22000		95000		130	0,3
PL-22000	13000	77500	1650	140	0.2

Anode weight: 0,2 g, Pressed density: 4,5 g/cm³ Sintering time: 20 min. Formation voltage: 70.1/

PL-22000

Typical Chemical Analysis

Elements	N	0	С	Fe	Nb	Si	Ti	W	Мо
ppm	200	2000	100	60	50	50	10	20	20

Typical Physical Characteristics

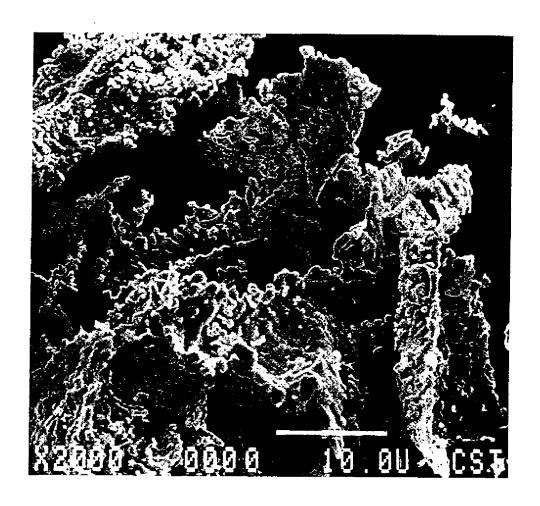
Scott Density (according to ASTM: B 329-76)

g/in³: 15-20 g/cm³: 0,9-1,3

Fisher Sub-Sieve Size (according to ASTM: B 330–82)

 μ m : 0,9–1,3

Screen Distribution (according to ASTM: B 214–76, E 11 100%–45 mesh



Tantalum Powder Capacitor Grade Grade 660

The application of grade 660 is in the high to highest working voltage area.

Because of the purity (EB-melting), this powder is very important for the production of capacitors with high reliability (MIL-Spec. No. C 39003)

Recommended conditions for processing

Sintering temperature: 1850–2000°C Sintering time: 30–40 minutes Pressed density: 7,5–9,5 g/cm³ Yield of capacitance: 1900–2400 µFV/g

Working voltage: 50 V

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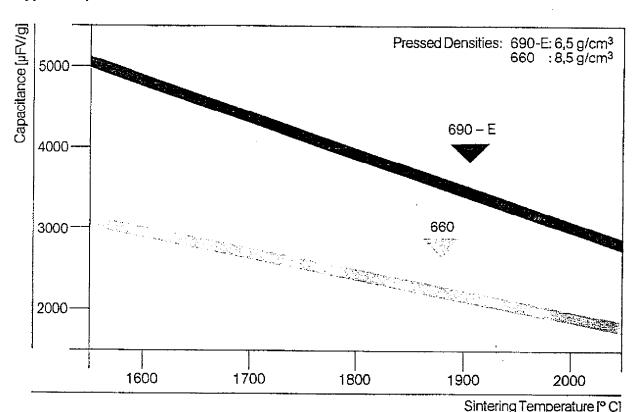
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Typical Capacitance



[Sintering Time 30 min.]

Typical Electrical Characteristics

Grade	μFV/g	uFV/	Sintering Temperature	VBD	DCL
		cm ³	(°C)	(V)	(nA/µFV)
660	2350	21800	1850	230	0.50
660	2000	19500	2000	250	0,30

Anode weight: 4,0 g, Pressed density: 8,5 g/cm³ Sintering time: 30 min, Formation voltage: 200 V

Typical Chemical Analysis

Elements	H_	N	0	С	Fe	Nb	Si	Ti	W	Мо
ppm			1300							

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Typical Physical Characteristics

Scott Density (according to ASTM No. B 329-76)

g/in³: 85 -100 g/cm³: 5,2- 6,1

Fisher Sub-Sieve Size (according to ASTM No. B 330-82)

μm : 8,0- 10,0

Screen Distribution (according to ASTM No. B 214-76, E11)

690-E is an improved EB-melted high capacitive powder. Its outstanding physical properties are: formability without binder, very good green strength and good flowability.

Recommended conditions for processing

Sintering temperature: 1600-1950°C Sintering time: 15-40 minutes,

can be pressed without binder

Pressed density: 6,5-7,5 g/cm³ 3000-5000 µFV/g Yield of capacitance:

Working voltage: up to 50 V

Typical Capacitance

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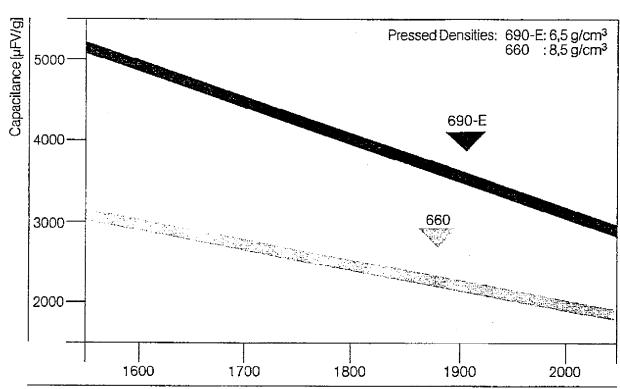
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Sintering Temperature [° C] [Sintering Time 30 min.]

Typical Electrical Characteristics

Grade	µFV/g	uFV/	Sintering Temperature	VBD	DCL
	, <u></u>	cm ³	(°C)	(V)	(nA/µFV)
690-E			1650	190	0,4
690 - E	3750	32000	1850	240	0,3

Anode weight: 1,0 g, Pressed density: 7,0 g/cm³ Sintering time: 30 min, Formation voltage: 200 V

690-E

Typical Chemical Analysis

Elements H N O C Fe Nb Si Ti W Mo ppm 10 35 1600 40 25 35 10 5 10 10

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Typical Physical Characteristics

Scott Density (according to ASTM: B 329-76)

 g/in^3 : 60 - 75 g/cm^3 : 3,6-4,6

Fisher Sub-Sieve Size (according to ASTM: B 330-82)

µm : 7–12

 Screen Distribution (according to ASTM: B 214–76, E 11)

 +200 mesh
 -200+325 mesh
 -325 mesh

 40-65%
 5-15%
 30-50%



690-S is a newly developed EB-melted high capacitance powder with all the physical properties of 690-E, such as excellent pressing characteristics without binder, good green strength and good flowability.

Recommended conditions for processing

Sintering temperature: 1600–1850°C
Sintering time: 30–40 minutes
Pressed density: 6,5–7,5 g/cm³

can be pressed without binder

Yield of capacitance: 4500-6000 µFV/g Working voltage: 35 V and over

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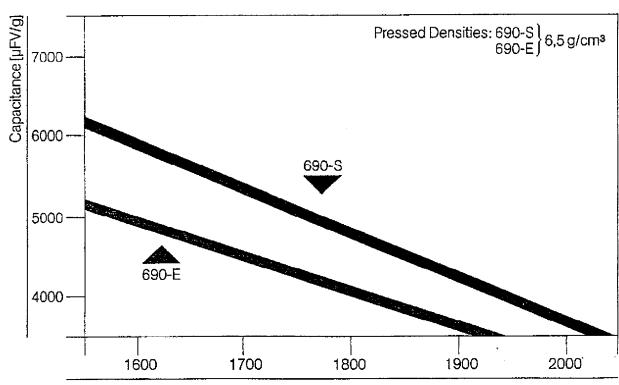
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Sintering Temperature [°C] [Sintering Time 30 min.]

Typical Electrical Characteristics

Grade	μFV/g	•	Sintering Temperature		DCL
		cm ³	(°C)	(V)	(nA/µFV)
690-S	5650	49000	1650	190	0,4
690-S	4250	41000	1850	240	0,3

Anode weight: 1,0 g, Pressed density: 7.0 g/cm³ Sintering time: 30 min, Formation voltage: 200 V

Typical Chemical Analysis

Elements	Н	Ν	0	С	Fe	Nb	Si	Ti	W	Мо
ppm	10	35	1700	40	25	35	10	5	10	10

Typical Physical Characteristics

Scott Density (according to ASTM: B 329-76)

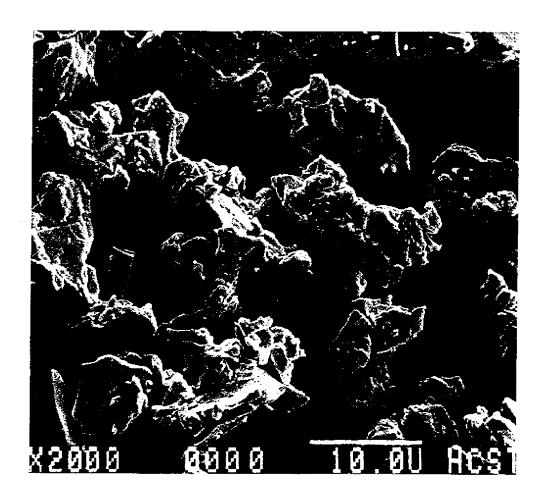
g/in³: 60 -75 g/cm³: 3,6-4,6

Fisher Sub-Sieve Size (according to ASTM: B 330–82)

µm : 4–9

Screen Distribution (according to ASTM; B 214–76, E 11)

+200 mesh	-200-325 mesh	-325 mesh
30-55%	3-10%	40-60%



Tantalum Powder Capacitor Grade Grade 900-HC

900-HC

900-HC represents a new class of EB-melted high capacitance powders. The capacitance increase compared to grade 690-E is about 25% at 1700°C sintering temperature.

The application of 900-HC is in the high working voltage area.

Recommended conditions for processing

Sintering temperature: 1600–1850°C
Sintering time: 20–40 minutes
Pressed density: 6,5–7,5 g/cm³

can be pressed without binder

Yield of capacitance: 4500-7000 µFV/g Working voltage: 35 V and over

Typical Capacitance

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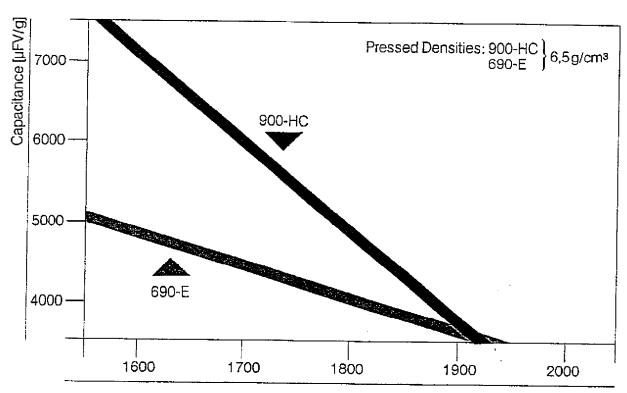
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Sintering Temperature [°C] [Sintering Time 30 min.]

Typical Electrical Characteristics

Grade	μFV/g	uFV/	Sintering Temperature	VBD	DCL
*****		cm ³	(°C)	(V)	(nA/µFV)
900-HC	6100	50000	1700	210	0.4
900-HC	4900	44000	1800	225	0.3

Anode weight: 1,0 g, Pressed density: 6,5 g/cm³ Sintering time: 30 min, Formation voltage: 200 V

900-HC

Typical Chemical Analysis

Elements H N O C Fe Nb Si Ti W Mo ppm 10 50 2000 40 35 35 10 5 10 10

Typical Physical Characteristics

Scott Density (according to ASTM; B 329-76)

 g/in^3 : 55 -70 g/cm^3 : 3,3-4,3

Fisher Sub-Sieve Size (according to ASTM: B 330-82)

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µm : 4-/

Screen Distribution (according to ASTM: B 214–76, E 11)

<u>-40 mesh</u> <u>-325 mesh</u> 100% 30-50%



900 HC

Scanning electron micrograph

Tantalum Powder Capacitor Grade Special Grade

Special Grade is an EB-melted high capacitance powder with smaller temperature-capacitance-coefficient compared to grade 690-E.

Special Grade

The outstanding physical properties such as good flowability and high pellet green strength are almost identical to grade 690-E.

Recommended conditions for processing

Sintering temperature: 1600-1950°C Sintering time: 15-40 minutes Pressed density: 6,5~7,5 g/cm³

can be pressed without binder

Yield of capacitance: 3000-5000 µFV/g Working voltage: 35 V and over

Typical Capacitance

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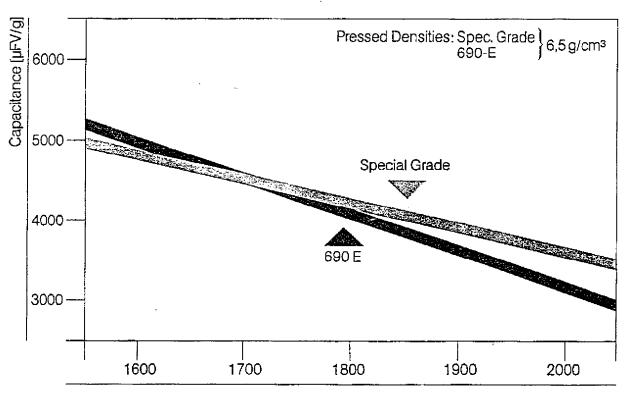
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Sintering Temperature [°C] [Sintering Time 30 min.]

Typical Electrical Characteristics

Grade	μFV/g	μFV/	Sintering Temperature	VBD	DCL
		cm ³	(°C)	(V)	(nA/µFV)
Spec. Grade	4600	33000	1650	195	0,4
Spec. Grade	3850	32500	1850	245	0,3

Anode weight: 1,0 g, Pressed density: 7,0 g/cm³ Sintering time: 30 min. Formation voltage: 200 V

Special Grade

Typical Chemical Analysis

Elements H N O C Fe Nb Si Ti W Mo ppm 10 35 1600 30 25 35 10 5 10 10

Typical Physical Characteristics

Scott Density (according to ASTM: B 329-76)

 g/in^3 : 60 -70 g/cm^3 : 3,6-4,3

Fisher Sub-Sieve Size (according to ASTM: B 330–82)

μm : 7–12

Screen Distribution (according to ASTM: B 214-76, E 11)

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<u>-40 mesh</u> <u>-325 mesh</u> 100% 30–50%



Special Grade Scanning electron micrograph

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Hermann C. Starck Berlin have been supplying sintered anodes for wet and dry capacitors since 1969.

Years of experience in producing capacitor grade tantalum powder also enables us to produce high quality sintered anodes. The aim of our anode production is to support existing production of our customers and not to compete with our customers.

Sintered Tantalum **Anodes**

In view of the enormous variety of types, data sheets for the individual anode types are not available.

We are generally prepared to meet anode specifications within the following data.

Anode form:

cylindrical, rectangular

Anode diameter: Anode length:

1,0 ~ 10,0 mm $0.5 - 20 \, \text{mm}$

Wire diameter:

 $0.25 - 0.8 \, \text{mm}$ 10 - 22 mm

Wire length:

(Standard figures: 10 mm, 15 mm,

20 mm)

Wire lead:

central, asymmetric

Capacitance:

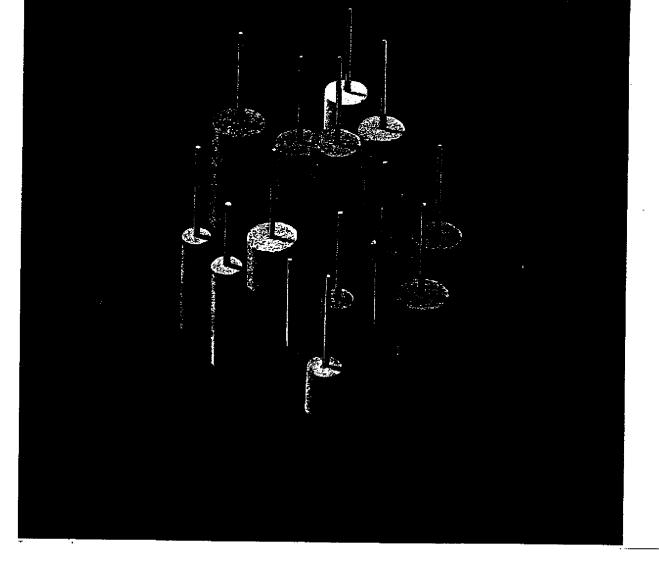
0,006 - 680 µF Formation voltage: up to 270 V

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Tantalum Metal Metallurgical Grade Powder

Scope: This specification covers the requirement for tantalum powder used for powder metallurgy.

Physical Analysis

Grain size:

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100%-70 mesh

Scott Density:

60-100 g/inch3

(according to ASTM:

B 329-76)

Fisher Sub-Sieve Size: 6-16 µm (according to ASTM: B 330-76)

Chemical Analysis (max values in ppm):

H	C	<u>N</u>	0	AL	Si
100	200	200	2000	50	200
<u>Cb</u>	W	Mo	Fe	Cr	Ni
200	200	200	200	50	50

Powder out of this grade can be used for tantalum mill products.

Especially in case of wire used in leads for tantalum capacitors and component parts, properties like resistance to grain growth during high temperature sintering and low leakage current are required.

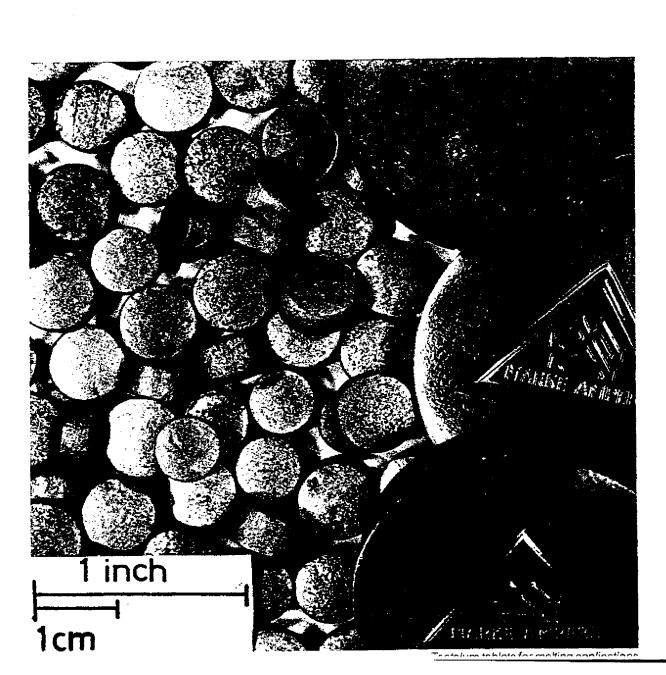
There are two starting materials commonly used for mill products: electron beam-/arc-melted ingots or pressed and sintered powder bars.

In case powder is used the powder has to bear all the characteristics of the final product.

Metallurgical grade powder by **HCST** is recommended for this purpose.

Regarding the specification we are prepared to meet customers' requirements.

Metallurgical Grade Powder



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Tantalum Metal Metallurgical Grade Compacts

Scope: This specification covers the requirement for tantalum to produce high-quality alloys by vacuum melting.

Metallur-

Compacts

gical

Grade

I. High Purity Grade - min. 99,8% Ta

Η Si Τi 10 300 150 50 600 100 20 30 <u>Fe</u>_ Se Cb Ag Şn Sb Te Pb Βi 150 10 200 10 10 5 10 10 5

II. Special Grade - min. 99,7% Ta

Н Ν Αl Si S Τi 500 10 300 1500 50 200 20 30 Fe Se Cb Αg Sn Şb Te Pb Bi 150 10 200 10 10 5 10 10 5

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High purity grade

(99,8% Ta) and

Special grade

(99,7% Ta) are available in tablets

Dimensions for Tablets

Diameter 5-10 mm (0,2"-0,4") Length 5-10 mm (0,2"-0,4")

Diameter 40 mm (1,57") Length 10-15 mm (0,4"-0,6")

Packaging

The standard package is 100 lbs per drum

The technical information of this data sheet represents our present knowledge. It does not form part of any sales contracts as guaranteed properties of the delivered material. Our delivery and sales conditions apply to all

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